

74F534 Octal D-Type Flip-Flop with 3-STATE Outputs

General Description

The 74F534 is a high speed, low-power octal D-type flip-flop featuring separate D-type inputs for each flip-flop and 3-STATE outputs for bus-oriented applications. A buffered Clock (CP) and Output Enable (\overline{OE}) are common to all flip-flops. The 74F534 is the same as the 74F374 except that the outputs are inverted.

Features

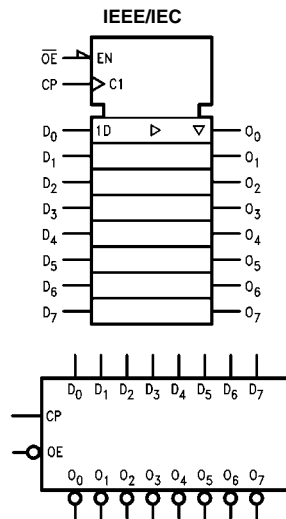
- Edge-triggered D-type inputs
- Buffered positive edge-triggered clock
- 3-STATE outputs for bus-oriented applications

Ordering Code:

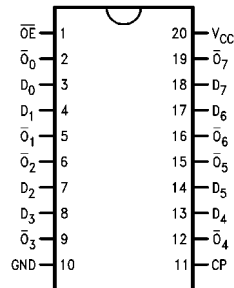
| Order Number | Package Number | Package Description |
|--------------|----------------|---|
| 74F534SC | M20B | 20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide |
| 74F534SJ | M20D | 20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74F534PC | N20A | 20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

| Pin Names | Description | U.L. | |
|-------------------------------------|--|--------------|---|
| | | HIGH/LOW | Input I_{IH}/I_{IL} Output I_{OH}/I_{OL} |
| D ₀ -D ₇ | Data Inputs | 1.0/1.0 | 20 μ A/-0.6 mA |
| CP | Clock Pulse Input (Active Rising Edge) | 1.0/1.0 | 20 μ A/-0.6 mA |
| \overline{OE} | 3-STATE Output Enable Input (Active LOW) | 1.0/1.0 | 20 μ A/-0.6 mA |
| $\overline{O_0}$ - $\overline{O_7}$ | Complementary 3-STATE Outputs | 150/40(33.3) | -3 mA/24 mA (20 mA) |

Function Table

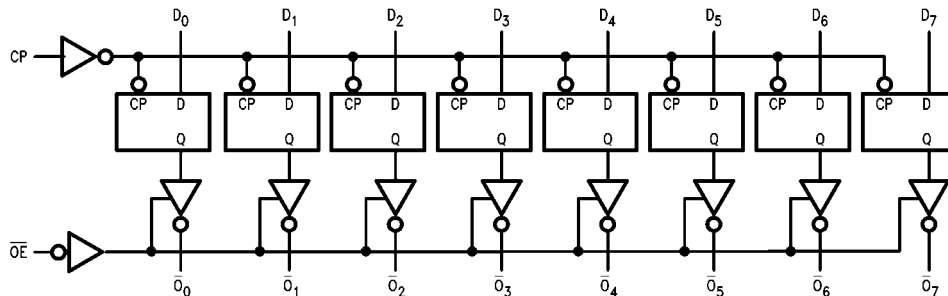
| Inputs | | | Output |
|--------|-----------------|---|------------------|
| CP | \overline{OE} | D | \overline{O} |
| ↗ | L | H | L |
| ↗ | L | L | H |
| L | L | X | $\overline{O_0}$ |
| X | H | X | Z |

H = HIGH Voltage Level L = LOW Voltage Level
 X = Immaterial Z = High Impedance
 ↗ = LOW-to-HIGH Clock Transition
 $\overline{O_0}$ = Value stored from previous clock cycle

Functional Description

The 74F534 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-STATE complementary outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH clock (CP) transition. With the Output Enable (\overline{OE}) LOW, the contents of the eight flip-flops are available at the outputs. When the \overline{OE} is HIGH, the outputs go to the high impedance state. Operation of the \overline{OE} input does not affect the state of the flip-flops.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

| | |
|--|--------------------------------------|
| Storage Temperature | -65°C to +150°C |
| Ambient Temperature under Bias | -55°C to +125°C |
| Junction Temperature under Bias | -55°C to +150°C |
| V _{CC} Pin Potential to Ground Pin | -0.5V to +7.0V |
| Input Voltage (Note 2) | -0.5V to +7.0V |
| Input Current (Note 2) | -30 mA to +5.0 mA |
| Voltage Applied to Output in HIGH State (with V _{CC} = 0V) | |
| Standard Output | -0.5V to V _{CC} |
| 3-STATE Output | -0.5V to +5.5V |
| Current Applied to Output in LOW State (Max) | twice the rated I _{OL} (mA) |
| ESD Last Passing Voltage (Min) | 4000V |

Recommended Operating Conditions

| | |
|------------------------------|----------------|
| Free Air Ambient Temperature | 0°C to +70°C |
| Supply Voltage | +4.5V to +5.5V |

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

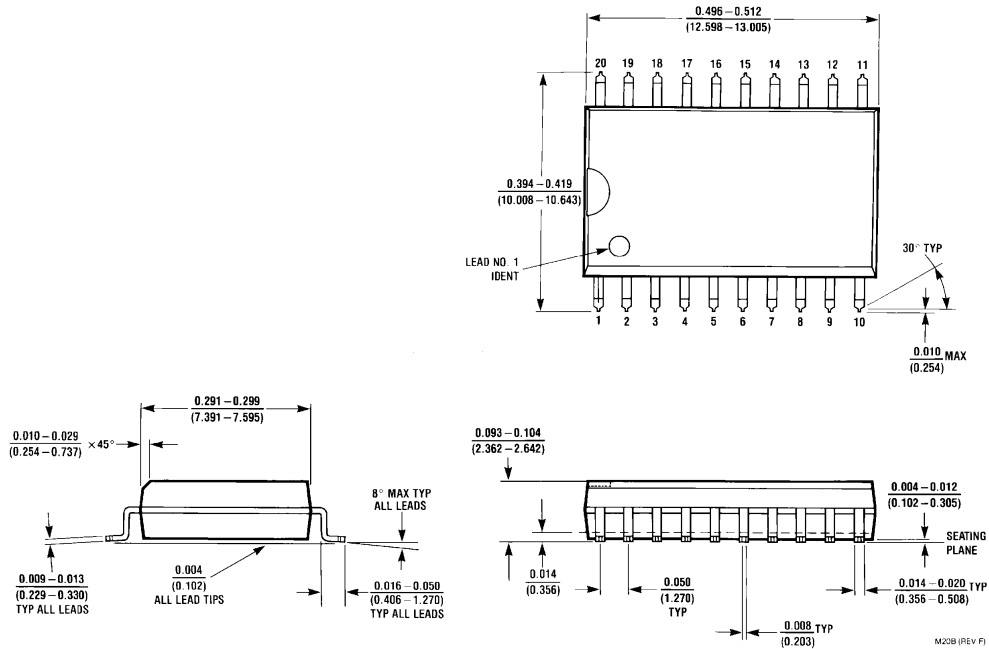
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

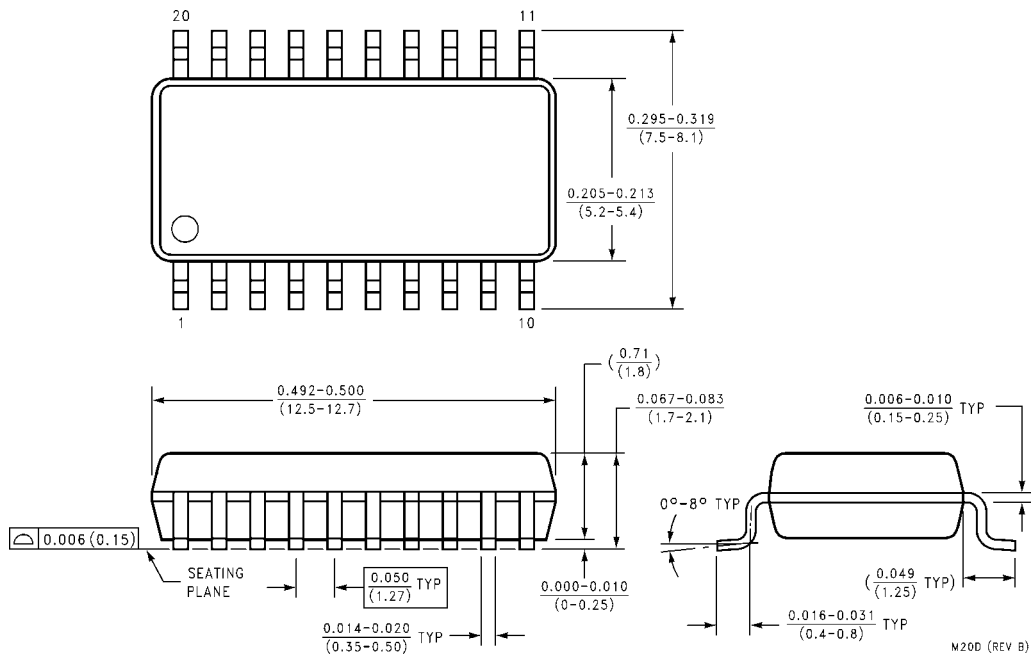
| Symbol | Parameter | Min | Typ | Max | Units | V _{CC} | Conditions |
|------------------|-----------------------------------|---------------------|-----|------|-------|-----------------|---|
| V _{IH} | Input HIGH Voltage | 2.0 | | | V | | Recognized as a HIGH Signal |
| V _{IL} | Input LOW Voltage | | | 0.8 | V | | Recognized as a LOW Signal |
| V _{CD} | Input Clamp Diode Voltage | | | -1.2 | V | Min | I _{IN} = -18 mA |
| V _{OH} | Output HIGH Voltage | 10% V _{CC} | 2.5 | | V | Min | I _{OH} = -1 mA |
| | | 10% V _{CC} | 2.4 | | | | I _{OH} = -3 mA |
| | | 5% V _{CC} | 2.7 | | | | I _{OH} = -1 mA |
| | | 5% V _{CC} | 2.7 | | | | I _{OH} = -3 mA |
| V _{OL} | Output LOW Voltage | 10% V _{CC} | | 0.5 | V | Min | I _{OL} = 24 mA |
| I _{IH} | Input HIGH Current | | | 5.0 | μA | Max | V _{IN} = 2.7V |
| I _{BVI} | Input HIGH Current Breakdown Test | | | 7.0 | μA | Max | V _{IN} = 7.0V |
| I _{CEX} | Output HIGH Leakage Current | | | 50 | μA | Max | V _{OUT} = V _{CC} |
| V _{ID} | Input Leakage Test | 4.75 | | | V | 0.0 | I _{ID} = 1.9 μA All Other Pins Grounded |
| I _{OD} | Output Leakage Circuit Current | | | 3.75 | μA | 0.0 | V _{IOD} = 1.50 μA All Other Pins Grounded |
| I _{IL} | Input LOW Current | | | -0.6 | mA | Max | V _{IN} = 0.5V |
| I _{OZH} | Output Leakage Current | | | 50 | μA | Max | V _{OUT} = 2.7V |
| I _{OZL} | Output Leakage Current | | | -50 | μA | Max | V _{OUT} = 0.5V |
| I _{OS} | Output Short-Circuit Current | -60 | | -150 | mA | Max | V _{OUT} = 0V |
| I _{ZZ} | Bus Drainage Test | | | 500 | μA | 0.0V | V _{OUT} = 5.25V |
| I _{CCZ} | Power Supply Current | | 55 | 86 | mA | Max | V _O = HIGH Z |

| AC Electrical Characteristics | | | | | | | | | |
|-------------------------------|-------------------------|--|-----|---|---|--|--|-------|-------|
| Symbol | Parameter | $T_A = +25^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50\text{ pF}$ | | | $T_A = -55^\circ\text{C to } +125^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50\text{ pF}$ | | $T_A = 0^\circ\text{C to } +70^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50\text{ pF}$ | | Units |
| | | Min | Typ | Max | Min | Max | Min | Max | |
| f_{MAX} | Maximum Clock Frequency | 100 | | | 60 | | 70 | | MHz |
| t_{PLH} | Propagation Delay | 4.0 | 6.5 | 8.5 | 4.0 | 10.5 | 4.0 | 10.0 | ns |
| t_{PHL} | CP to \overline{O}_n | 4.0 | 6.5 | 8.5 | 4.0 | 11.0 | 4.0 | 10.0 | |
| t_{PZH} | Output Enable Time | 2.0 | 9.0 | 11.5 | 2.0 | 14.0 | 2.0 | 12.5 | ns |
| t_{PZL} | | 2.0 | 5.8 | 7.5 | 2.0 | 10.0 | 2.0 | 8.5 | |
| t_{PHZ} | Output Disable Time | 1.5 | 5.3 | 7.0 | 1.5 | 8.0 | 1.5 | 8.0 | |
| t_{PLZ} | | 1.5 | 4.3 | 5.5 | 1.5 | 7.5 | 1.5 | 6.5 | |
| AC Operating Requirements | | | | | | | | | |
| Symbol | Parameter | $T_A = +25^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ | | $T_A = -55^\circ\text{C to } +125^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ | | $T_A = 0^\circ\text{C to } +70^\circ\text{C}$ $V_{CC} = +5.0\text{V}$ | | Units | |
| | | Min | Max | Min | Max | Min | Max | | |
| $t_S(H)$ | Setup Time, HIGH or LOW | 2.0 | | 2.0 | | 2.0 | | ns | |
| $t_S(L)$ | D_n to CP | 2.0 | | 2.5 | | 2.0 | | | |
| $t_H(H)$ | Hold Time, HIGH or LOW | 2.0 | | 2.0 | | 2.0 | | ns | |
| $t_H(L)$ | D_n to CP | 2.0 | | 2.5 | | 2.0 | | | |
| $t_W(H)$ | CP Pulse Width | 7.0 | | 7.0 | | 7.0 | | ns | |
| $t_W(L)$ | HIGH or LOW | 6.0 | | 6.0 | | 6.0 | | | |

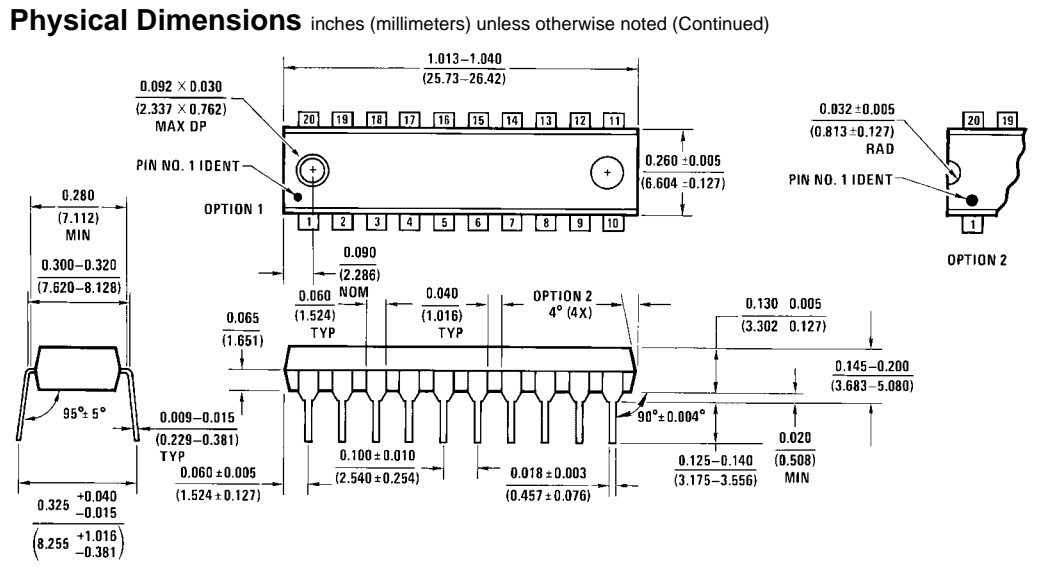
Physical Dimensions inches (millimeters) unless otherwise noted



20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M20B



20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M20D



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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